

<b>Notice of References Cited</b>	Application/Control No. 10/614,687	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Ryan F. Pitaro	Art Unit 2174	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name		Classification
*	A	US-6,029,198 A	02-2000	Iizuka, Yoshio		709/223
*	B	US-6,535,756 B1	03-2003	Simon et al.		600/424
*	C	US-2003/0076336	04-2003	Fukao et al.		345/589
	D	US-				
	E	US-				
	F	US-				
	G	US-				
	H	US-				
	I	US-				
	J	US-				
	K	US-				
	L	US-				
	M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Allegro, three-state, 2002, Page 1
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.